

Notice of References Cited	Application/Control No. 09/899,189	Applicant(s)/Patent Under Reexamination SEIDL ET AL.	
	Examiner Hoai V Pham	Art Unit 2814	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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